ARTICLE – Supporting Information

Understanding stress-induced disorder and breakage in organic crystals: beyond crystal structure anisotropy

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Contents

Crystal data	Page 1
SEM images of CBZ·2H ₂ O subjected to impact tests	Page 2
Transmission electron microscopy (TEM) of CBZ Form II	Page 5
Sample identification – Additional SEM images of CBZ·2H ₂ O	Page
6	
Transmission electron microscopy (TEM) of 2CBZ·BZQ	Page 8
Transmission electron microscopy (TEM) of CBZ·2H ₂ O	Page 9
Sample identification – PXRD	Page 10
References	Page 12

Crystal data

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Table 21 -	Crystallograph	lic data of the	e CBZ mun	ticomponent	crystai	torms

Crystal form	CBZ·2H ₂ O	2CBZ·BZQ	CBZ·FORM	2CBZ·DIOX ^a
Formula	(C ₁₅ H ₁₂ N ₂ O) (H ₂ O) ₂	$(C_{15}H_{12}N_2O)_2(C_6H_4O_2)$	(C ₁₅ H ₁₂ N ₂ O) (CH ₃ NO)	$(C_{15}H_{12}N_2O)_2(C_4H_8O_2)$
MW/g.mol ⁻¹	272.30	580.63	281.31	560.63
Т/К	120	100	100	180
Crystal system	Monoclinic	Monoclinic	Triclinic	Monoclinic
Space group	P21/c	P21/c	<i>P</i> -1	P21/n
a/Å	10.066(2)	10.3335(18)	5.1077(11)	16.7776(16)
b/Å	28.719(5)	27.611(5)	16.057(3)	4.9175(5)
c/Å	4.831(1)	4.9960(9)	17.752(4)	17.991(17)
α/°	90	90	73.711(3)	90
β/ °	103.45(1)	102.275(3)	89.350(3)	107.814(5)
γ / °	90	90	88.636(3)	90
V/ų	1358.3	1392.9	1397.1	1413.2(2)
Z/Z'	4/1	2/0.5	4/2	2/0.5
ρ/g.cm⁻³	1.332	1.384	1.337	1.318
R-factor/%	7.29	5.45	7.66	7.27
CSD refcode	FEFNOT02	UNEYOB	UNIBOI	QABHOU
Reference	Harris <i>et al.</i> (2005) ¹	Fleischman <i>et al.</i> (2003) ²	Fleischman <i>et al.</i> (2003) ²	Schneider-Rauber <i>et al</i> . (2020) ³

^a The structure of 2CB2-DIOX can be described with a supercell in space group P21/c, with dimensions a = 28.071(2), b = 4.9171(4), c = 20.5138(14) Å, $\alpha = \gamma = 90$, $\beta = 94.177(4)^\circ$. Details are given in Schneider-Rauber *et al.* (2021).

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SEM images of CBZ·2H₂O subjected to impact tests

The Scirocco disperser of Mastersizer 2000 and the aerodynamic disperser of Morphologi G3 (Malvern Panalytical) were used for these studies.^{4–6} Tests using these instruments provided distinct evidence for the extent of mechanically-induced breakage. At high impact velocities (**Figure S1**), crystal size changed considerably with breakage. At low particle impact velocity (**Figures S2** and **S3**), overall particle shape and size were generally maintained and breakage was limited to geometric fracture along the shortest dimension.⁷



Figure S1 – SEM micrographs comparing (in blue) fresh CBZ·2H₂O crystals to (in pink) post impact samples (Scirocco disperser, different dispersion pressures giving rise to different impact velocities in the range 20-30 m/s). Face assignments are based on the effect of the vacuum on the appearance of the {h00} and {0k0} faces - see manuscript.

Journal Name



Figure S2 – SEM micrographs showing the results of impact tests at low impact velocities on the CBZ·2H₂O sample (Morphologi G3, 1 bar of dispersion pressure).

ARTICLE



Figure S3 – SEM micrographs showing the results of impact tests at low impact velocities on the CBZ·2H₂O sample (Morphologi G3, 2 bar of dispersion pressure).

Transmission electron microscopy (TEM) of CBZ Form II



Figure S4 – Indexing of zone axis diffraction patterns of carbamazepine Form II (diffraction patterns obtained for samples of crystals of anhydrous CBZ Form II were of significantly better quality in comparison to data collected for CBZ·2H₂O under similar conditions). a) Experimental zone axis electron diffraction pattern of the [010] zone axis. b) Simulated electron diffraction pattern of the [010] zone axis from CSD structure CBMZPN03 (a = b = 35.454 Å, c = 5.253 Å, $\alpha = \beta = 90^{\circ}$, $\gamma = 120^{\circ}$). c) Experimental zone axis electron diffraction pattern of the [-1-21] zone axis. d) Simulated electron diffraction pattern of the [-1-21] zone axis. d) Simulated electron diffraction pattern of the [-1-21] zone axis from CSD structure CBMZPN03.



Figure S5 – TEM image of crystals of carbamazepine Form II. The bright field images confirm the absence of pores regardless of the time inside the vacuum chamber.

Sample identification – additional SEM images of CBZ·2H₂O



Figure S6 – Additional surface features on {h00} surfaces of CBZ·2H₂O. a) SEM micrograph of a dehydrated sample showing texture running across the cracks (left) and the molecular features associated to the textured domains (right). Angles between (020) planes and CBZ dimers and between pairs of CBZ dimers are represented by α and β , respectively. More texture images are available in **Figure S7**. b) incomplete crack propagation as highlighted by the arrows.

Journal Name



Figure S7 – SEM micrographs of the {h00} surfaces of CBZ·2H₂O fresh crystals showing its texture in detail.



Figure S8 – SEM micrographs of CBZ-2H₂O prepared in laboratory scale and used in the general characterisation of crystal breakage as a consequence of vacuum and thermal treatment. The sample shown in **a**) presents {0k0} preferred surfaces, while the sample shown in **b**) presents {h00} dominant surfaces. See Experimental Section for details about the crystallisation conditions.

Transmission electron microscopy (TEM) of 2CBZ·BZQ



Figure S9 – TEM bright field image and diffraction pattern of 2CBZ·BZQ crystals (based on CSD structure UNEYOB, a = 10.334 Å, b = 27.612 Å, c = 4.996 Å, $\alpha = \gamma = 90^{\circ}$, $\beta = 102.275^{\circ}$). The light/dark interfaces and the characteristics of the diffraction spots indicate twinning on (100).

Transmission electron microscopy (TEM) of CBZ·2H₂O



Figure S10 – TEM bright field image and diffraction pattern of CBZ·2H₂O obtained from cryo-TEM experiments. *a*) Bright field image. *b*) Respective experimental zone axis electron diffraction pattern. The [100] zone axis is shown in the simulated electron diffraction pattern (*c*) based on the CSD structure FEFNOT02 (a=10.066 Å, b=28.719 Å, c=4.831 Å, α =y=90°, β =103.45°). The additional rows of spots seen in the experimental diffraction pattern in comparison to the simulated pattern suggest the presence of defects along the *b* direction.

ARTICLE

Sample identification – PXRD



Figure S11 - PXRD patterns illustrating the preferred orientation of CBZ·2H₂O samples compared to the pattern calculated from FEFNOT02. While the samples prepared in laboratory scale were used in the general characterisation of crystal breakage because of vacuum and thermal treatment, the sample prepared in large scale was used in impact tests. See Experimental Section for details about the crystallisation conditions.



Figure S12 - PXRD patterns illustrating the preferred orientation of the 2CBZ·BZQ sample compared to the pattern calculated from UNEYOB. See Experimental Section for details about the crystallisation conditions.



Figure S13 - PXRD patterns illustrating the preferred orientation of the CBZ-FORM sample compared to the pattern calculated from UNIBOI. See Experimental Section for details about the crystallisation conditions.



Figure S14 - PXRD patterns illustrating the preferred orientation of the 2CBZ·DIOX sample compared to the pattern calculated from QABHOU. See Experimental Section for details about the crystallisation conditions.

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